

<b>Notice of References Cited</b>	Application/Control No. 10/763,172	Applicant(s)/Patent Under Reexamination MITCHELL ET AL.	
	Examiner Phung T. Nguyen	Art Unit 2632	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,472,986 B1	10-2002	Sorriaux, Pierre	340/571
	B	US-5,552,759	09-1996	Stoyka, David S.	340/426.33
	C	US-5,317,304	05-1994	Choi, Alexander K.	340/571
	D	US-3,988,724	10-1976	Anderson, David John	340/539.31
	E	US-2001/0040507 A1	11-2001	Eckstein et al.	340/572.4
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.